

< High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

# CMH600DC-66X

HIGH POWER SWITCHING USE  
INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

## CMH600DC-66X



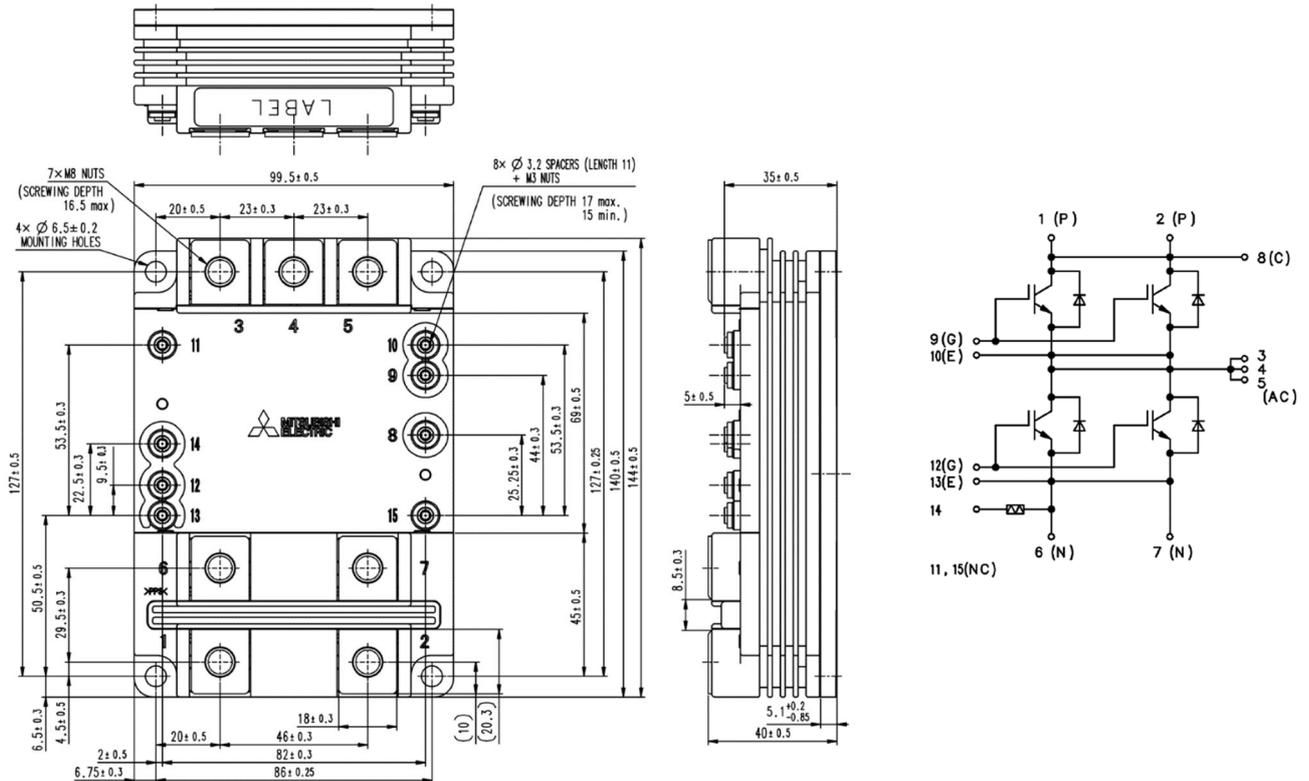
- $I_C$ .....600A
- $V_{CES}$ .....3300V
- 2-elements in a Pack
- Insulated Type (AlSiC base type)
- CSTBT™(III)
- SiC Schottky-Barrier Diode

## APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers

## OUTLINE DRAWING & CIRCUIT DIAGRAM

Dimensions in mm



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## MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
V <sub>CES</sub>	Collector-emitter voltage	V <sub>GE</sub> = 0 V, T <sub>J</sub> = -40...+150 °C	3300	V
		V <sub>GE</sub> = 0 V, T <sub>J</sub> = -50 °C	3200	
V <sub>GES</sub>	Gate-emitter voltage	V <sub>CE</sub> = 0 V, T <sub>J</sub> = 25 °C	± 20	V
I <sub>C</sub>	Collector current	DC, T <sub>c</sub> = 90 °C	600	A
I <sub>CRM</sub>		Pulse (Note 1)	1200	A
I <sub>E</sub>	Emitter current (Note 2)	DC	600	A
I <sub>ERM</sub>		Pulse (Note 1)	1200	A
P <sub>tot</sub>	Maximum power dissipation (Note 3)	T <sub>c</sub> = 25 °C, IGBT part	4100	W
V <sub>iso</sub>	Isolation voltage	RMS, sinusoidal, f = 60 Hz, t = 1 min	6000	V
Q <sub>PD</sub>	Partial discharge	Charged part to the base-plate V <sub>1</sub> = 3500 V <sub>rms</sub> , V <sub>2</sub> = 2600 V <sub>rms</sub> AC 60 Hz, T <sub>c</sub> = 25 °C (acc. to IEC 61287-1)	10	pC
T <sub>J</sub>	Junction temperature	—	-50 ~ +150	°C
T <sub>Jop</sub>	Operating junction temperature	—	-50 ~ +150	°C
T <sub>stg</sub>	Storage temperature	—	-55 ~ +150	°C
t <sub>psc</sub>	Short circuit pulse width	V <sub>CC</sub> ≤ 2400 V, V <sub>GE</sub> = ±15 V R <sub>G(on)</sub> = 2.2 Ω, R <sub>G(off)</sub> = 51 Ω T <sub>J</sub> = 150 °C, C <sub>GE</sub> = 33 nH, L <sub>S</sub> = 65 nH	10	μs

## ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit		
			Min.	Typ.	Max.			
I <sub>CES</sub>	Collector cutoff current	V <sub>CE</sub> = V <sub>CES</sub> , V <sub>GE</sub> = 0V	T <sub>J</sub> = 25 °C	—	—	2.0	mA	
			T <sub>J</sub> = 125 °C	—	2.0	—		
			T <sub>J</sub> = 150 °C	—	20.0	—		
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 60 mA, T <sub>J</sub> = 25 °C	6.5	7.0	7.5	V		
I <sub>GES</sub>	Gate leakage current	V <sub>GE</sub> = V <sub>GES</sub> , V <sub>CE</sub> = 0 V, T <sub>J</sub> = 25 °C	-0.5	—	0.5	μA		
V <sub>CESat</sub>	Collector-emitter saturation voltage	I <sub>C</sub> = 600 A (Note 4) V <sub>GE</sub> = 15 V	T <sub>J</sub> = 25 °C	—	2.30	—	V	
			T <sub>J</sub> = 125 °C	—	2.80	—		
			T <sub>J</sub> = 150 °C	—	2.90	3.30		
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 10 V, V <sub>GE</sub> = 0 V, f = 100 kHz T <sub>J</sub> = 25 °C	—	53.4	—	nF		
C <sub>oes</sub>	Output capacitance		—	3.8	—	nF		
C <sub>res</sub>	Reverse transfer capacitance		—	0.48	—	nF		
Q <sub>G</sub>	Total gate charge	V <sub>CC</sub> = 1800 V, I <sub>C</sub> = 600 A, V <sub>GE</sub> = ±15 V	—	3.6	—	μC		
t <sub>d(on)</sub>	Turn-on delay time	V <sub>CC</sub> = 1800 V I <sub>C/E</sub> = 600 A V <sub>GE</sub> = ±15 V R <sub>G(on)</sub> = 2.2 Ω, C <sub>GE</sub> = 33 nF L <sub>S</sub> = 65 nH	T <sub>J</sub> = 150 °C	—	—	1.25	μs	
t <sub>r</sub>	Rise time		T <sub>J</sub> = 150 °C	—	—	0.50	μs	
E <sub>on(10%)</sub>	Turn-on switching energy per pulse (Note 5)		T <sub>J</sub> = 25 °C	—	0.27	—	J	
			T <sub>J</sub> = 125 °C	—	0.29	—		
			T <sub>J</sub> = 150 °C	—	0.30	—		
E <sub>on</sub>	Turn-on switching energy per pulse		T <sub>J</sub> = 25 °C	—	0.29	—	J	
			T <sub>J</sub> = 125 °C	—	0.34	—		
			T <sub>J</sub> = 150 °C	—	0.35	—		
E <sub>off_diode(10%)</sub>	Diode-off switching energy per pulse (Note 2, 5)		Inductive load	T <sub>J</sub> = 25 °C	—	0.01	—	J
				T <sub>J</sub> = 125 °C	—	0.01	—	
		T <sub>J</sub> = 150 °C		—	0.01	—		
Q <sub>C(10%)</sub>	Total capacitive charge (Note 2, 6)		T <sub>J</sub> = 25 °C	—	8.55	—	μC	
			T <sub>J</sub> = 125 °C	—	9.25	—		
			T <sub>J</sub> = 150 °C	—	10.0	—		

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Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
V <sub>EC</sub>	Emitter-collector voltage (Note 2)	I <sub>E</sub> = 600 A (Note 4) V <sub>GE</sub> = 0 V	T <sub>J</sub> = 25 °C	—	2.25	—	V
			T <sub>J</sub> = 125 °C	—	3.55	—	
			T <sub>J</sub> = 150 °C	—	4.55	7.00	
t <sub>d(off)</sub>	Turn-off delay time	V <sub>CC</sub> = 1800 V I <sub>C</sub> = 600 A V <sub>GE</sub> = ±15 V R <sub>G(off)</sub> = 51 Ω C <sub>GE</sub> = 33 nF L <sub>S</sub> = 65 nH	T <sub>J</sub> = 150 °C	—	—	5.00	μs
t <sub>f</sub>	Fall time		T <sub>J</sub> = 150 °C	—	—	1.00	μs
E <sub>off(10%)</sub>	Turn-off switching energy per pulse (Note 5)		T <sub>J</sub> = 25 °C	—	0.68	—	J
		T <sub>J</sub> = 125 °C	—	0.91	—		
		T <sub>J</sub> = 150 °C	—	0.92	—		
E <sub>off</sub>	Turn-off switching energy per pulse	Inductive load	T <sub>J</sub> = 25 °C	—	0.75	—	J
			T <sub>J</sub> = 125 °C	—	1.03	—	
			T <sub>J</sub> = 150 °C	—	1.04	—	

## THERMAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R <sub>th(j-c)Q</sub>	Thermal resistance	Junction to Case, IGBT part, 1/2 module	—	—	30.0	K/kW
R <sub>th(j-c)D</sub>		Junction to Case, FWDi part, 1/2 module	—	—	45.0	K/kW
R <sub>th(c-s)</sub>	Contact thermal resistance	Case to heat sink, 1/2 module λ <sub>grease</sub> = 1 W/m·K, D <sub>(c-s)</sub> = 70 μm	—	16.0	—	K/kW

## MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
M <sub>t</sub>	Mounting torque	Main terminals screw M8 (Note 7)	7.0	—	14.0	N·m
M <sub>s</sub>		Mounting screw M6	3.0	—	6.0	N·m
M <sub>t</sub>		Auxiliary terminals screw M3	0.4	—	0.8	N·m
m	Mass	—	—	0.80	—	Kg
CTI	Comparative tracking index	—	600	—	—	—
d <sub>a</sub>	Clearance	Between terminals and baseplate	19.5	—	—	Mm
d <sub>s</sub>	Creepage distance	—	32.0	—	—	Mm
L <sub>P(P-N)</sub>	Parasitic stray inductance	Between terminal 1, 2 and terminal 6, 7	—	14.0	—	nH
R <sub>CC+EE'</sub>	Internal lead resistance	T <sub>c</sub> = 25 °C, 1/2 module	—	0.33	—	mΩ

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## NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R <sub>25</sub>	Zero-power resistance	T <sub>c</sub> = 25 °C	—	5.00	—	kΩ
B <sub>(25/50)</sub>	B-constant (Note 8)	Approximate by equation	—	3375	—	K

Note 1. Pulse width and repetition rate should be such that junction temperature (T<sub>j</sub>) does not exceed T<sub>jop,max</sub> rating.

Note 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD<sub>i</sub>).

Note 3. Junction temperature (T<sub>j</sub>) should not exceed T<sub>L,max</sub> rating (150°C).

Note 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note 5. The integration range of switching energies is from 10%V<sub>CE</sub> to 10%I<sub>C</sub>(I<sub>E</sub>).

Note 6. The integration range of total capacitive charge is from I<sub>E</sub>=0A to 10%I<sub>E</sub>.

Note 7 This is the case when installing the product on the bus bar.

Note 8.  $B_{(25/50)} = \ln \left( \frac{R_{25}}{R_{50}} \right) / \left( \frac{1}{T_{25}} - \frac{1}{T_{50}} \right)$

R<sub>25</sub>: resistance at 25 °C

R<sub>50</sub>: resistance at 50 °C

T<sub>25</sub> [K]: T<sub>25</sub> = 25 [°C] + 273.15 = 298.15 [K]

T<sub>50</sub> [K]: T<sub>50</sub> = 50 [°C] + 273.15 = 323.15 [K]

R<sub>25</sub>: resistance at absolute temperature T<sub>25</sub> [K]; T<sub>25</sub> = 25 [°C] + 273.15 = 298.15 [K]

R<sub>50</sub>: resistance at absolute temperature T<sub>50</sub> [K]; T<sub>50</sub> = 50 [°C] + 273.15 = 323.15 [K]

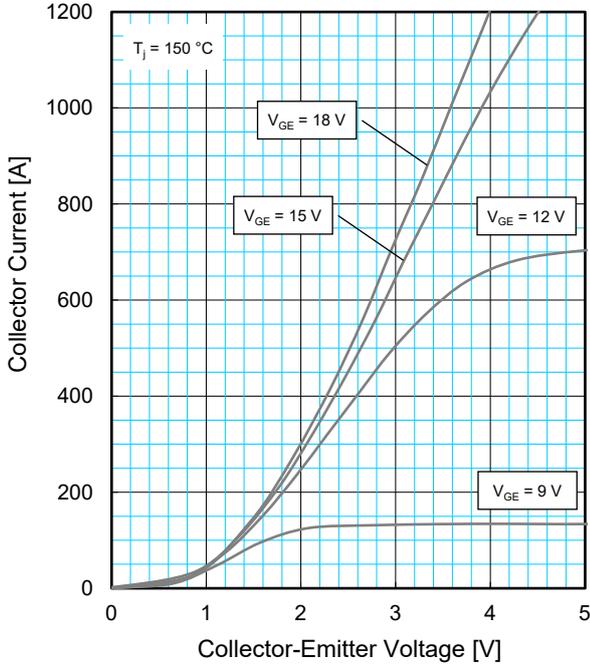
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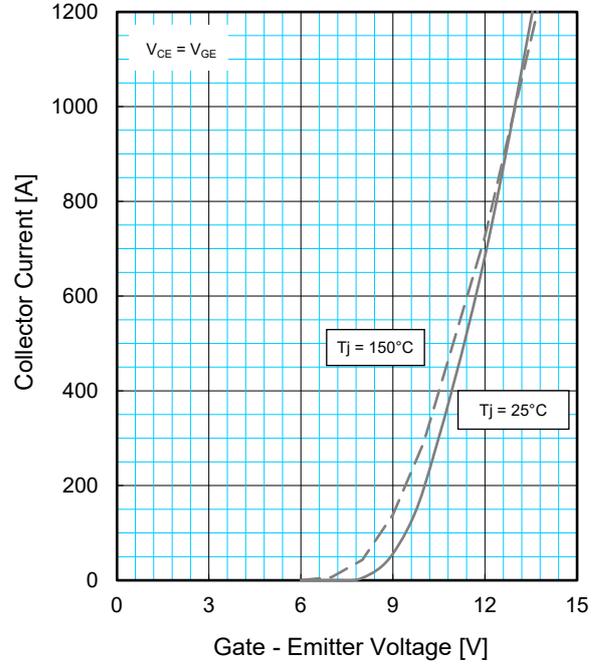
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## PERFORMANCE CURVES

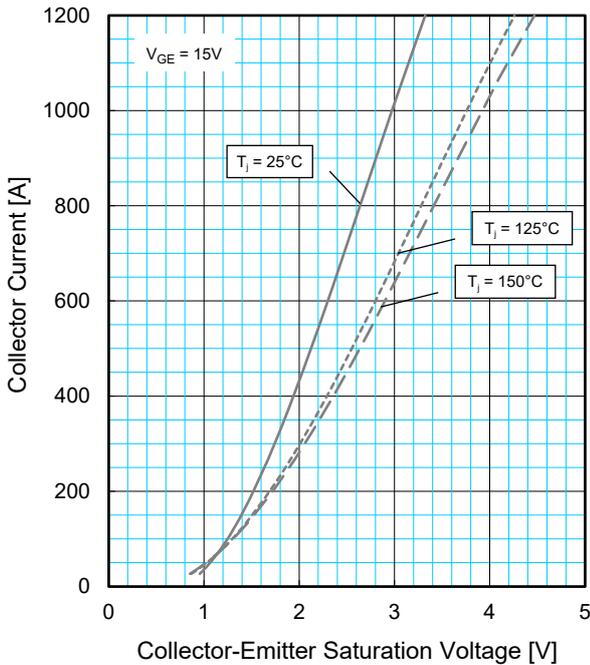
**OUTPUT CHARACTERISTICS (TYPICAL)**



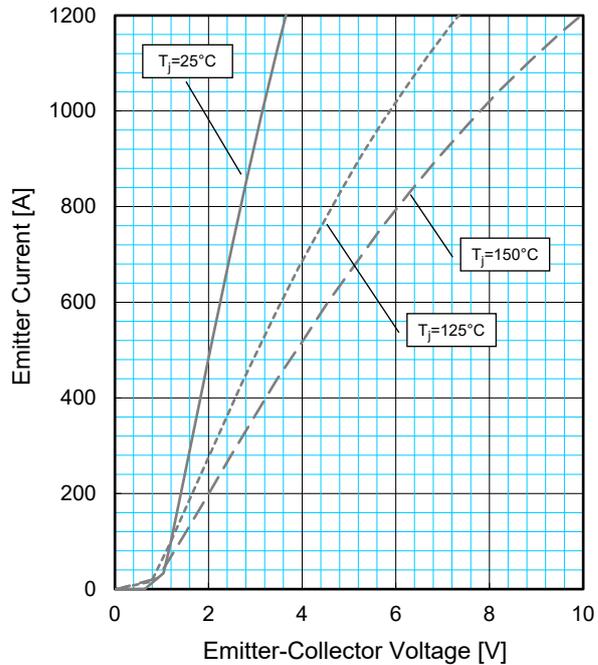
**TRANSFER CHARACTERISTICS (TYPICAL)**



**COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)**



**FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)**

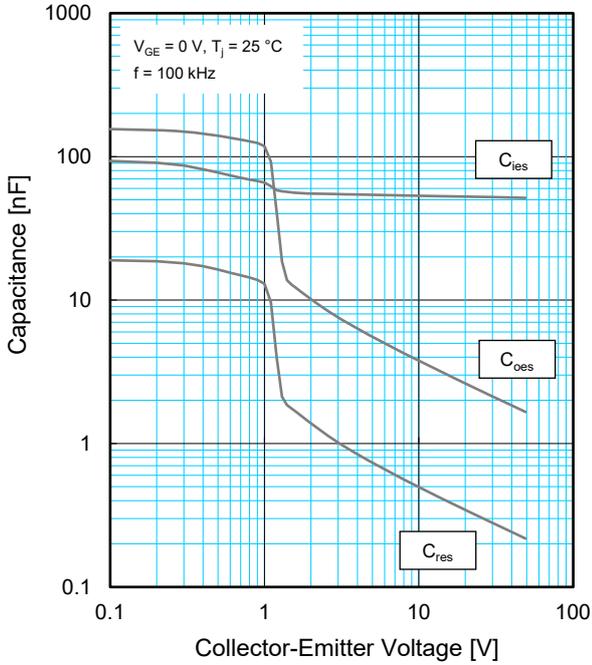


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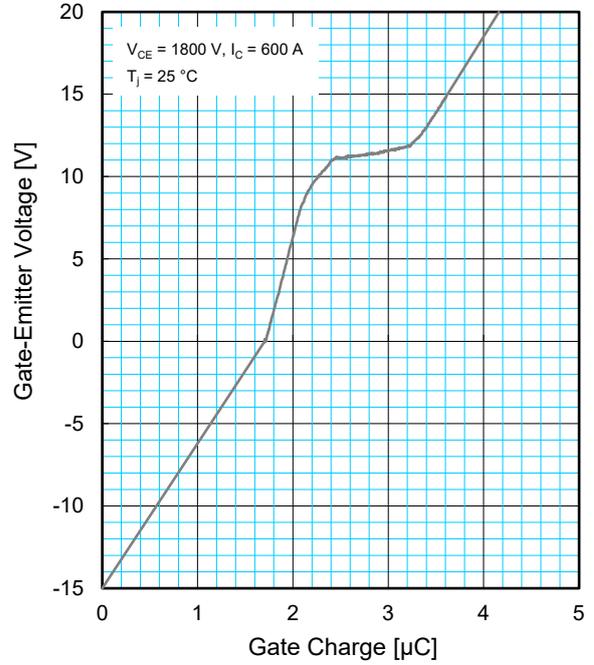
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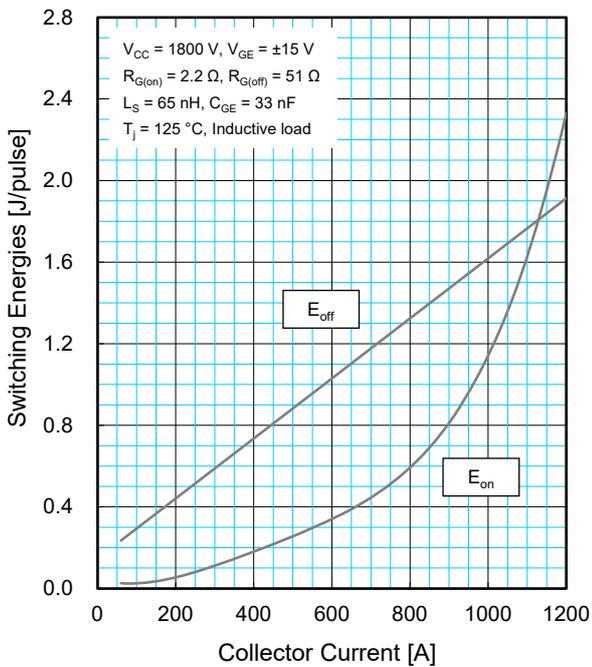
**CAPACITANCE CHARACTERISTICS (TYPICAL)**



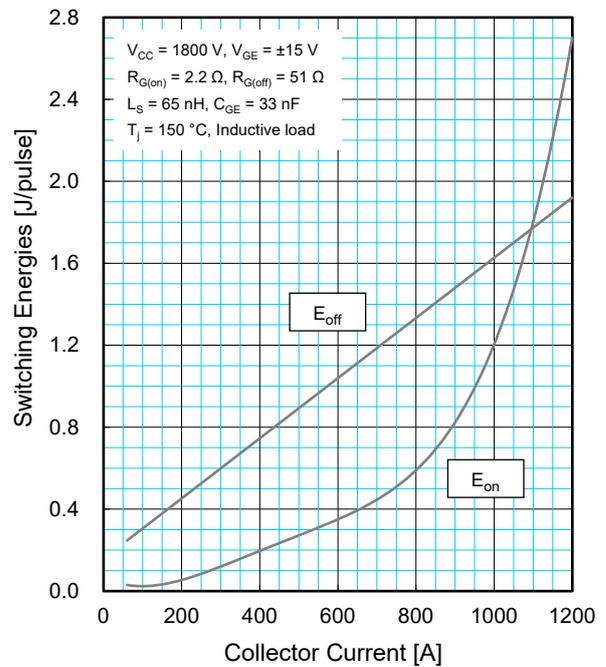
**GATE CHARGE CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)**



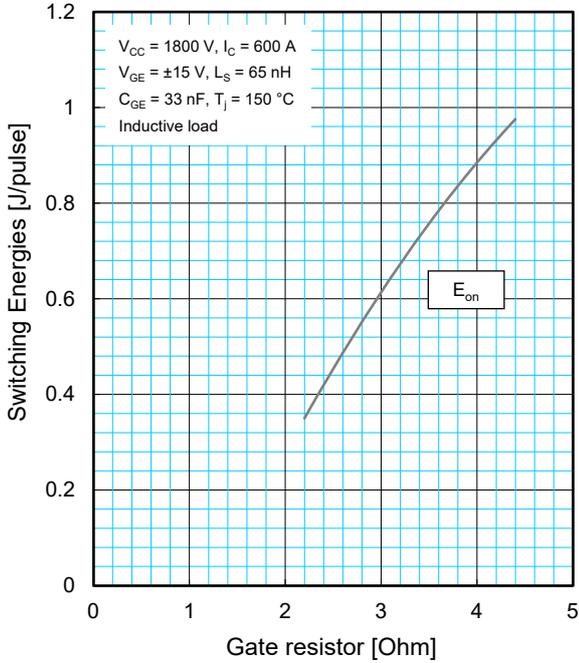
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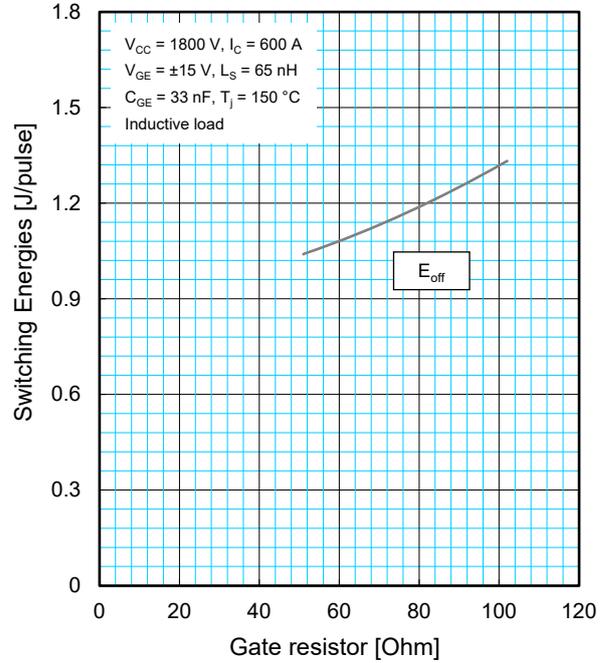
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## PERFORMANCE CURVES

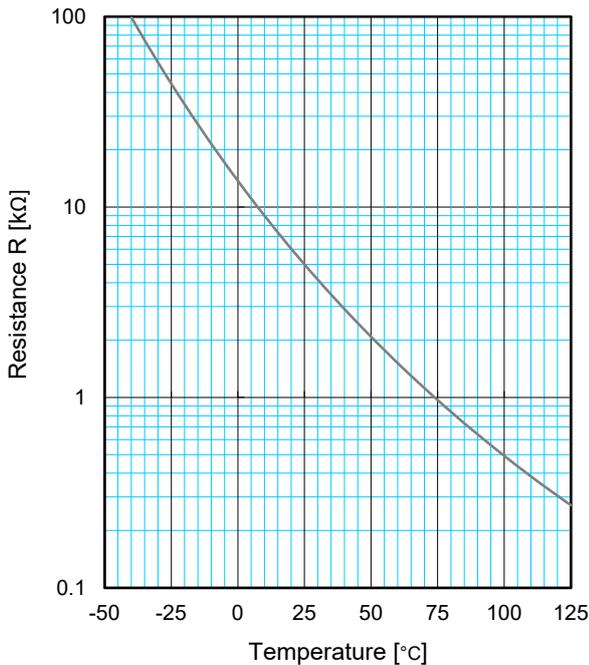
**HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)**



**NTC THERMISTOR TEMPERATURE CHARACTERISTICS (TYPICAL)**



# CMH600DC-66X

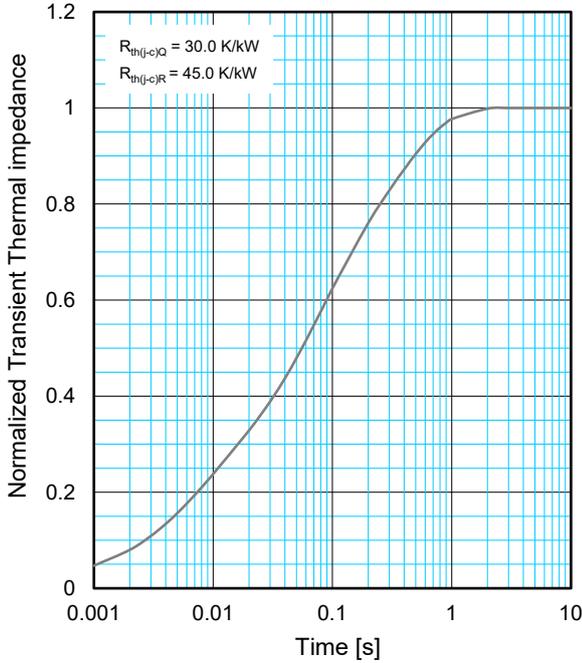
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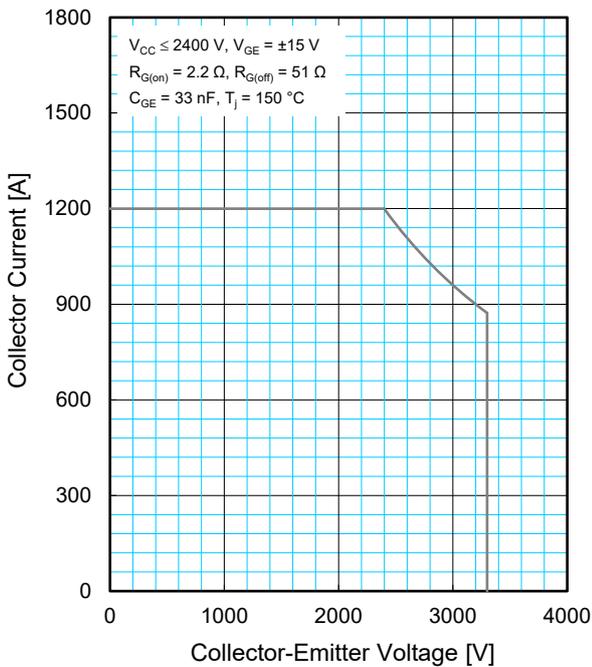
### TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



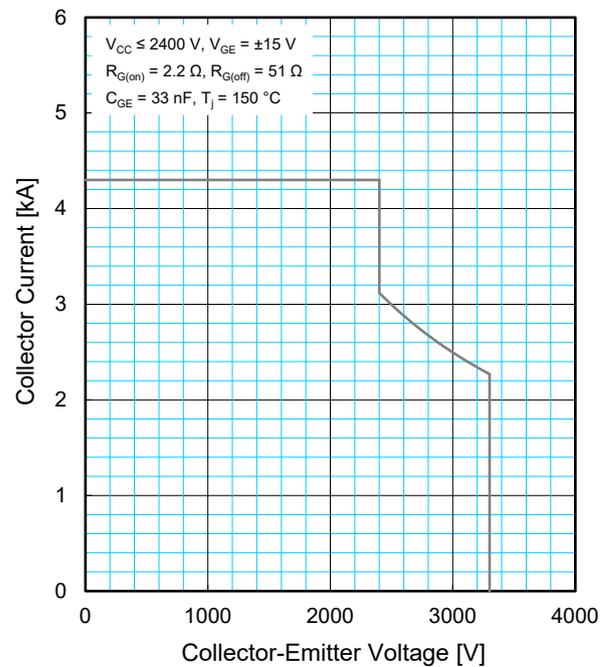
$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp\left(-\frac{t}{\tau_i}\right) \right\}$$

	1	2	3	4
$R_i / R_{th(j-c)}$	0.0096	0.1893	0.4044	0.3967
$\tau_i$ [s]	0.0001	0.0058	0.0602	0.3512

### REVERSE BIAS SAFE OPERATING AREA (RBSOA)



### SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



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